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# H-Bridge in APM16 Series for LLC and Phase-shifted DC-DC Converter

## NXV65HR51DZ1, NXV65HR51DZ2

#### **Features**

- SIP or DIP H-Bridge Power Module for On-board Charger (OBC) in EV or PHEV
- 5 kV/1 sec Electrically Isolated Substrate for Easy Assembly
- Creepage and Clearance per IEC60664-1, IEC 60950-1
- Compact Design for Low Total Module Resistance
- Module Serialization for Full Traceability
- Lead Free, RoHS and UL94V-0 Compliant
- Automotive Qualified per AEC Q101 and AQG324 Guidelines

#### **Applications**

• DC-DC Converter for On-board Charger in EV or PHEV

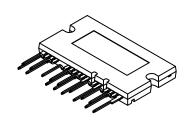
#### **Benefits**

- Enable Design of Small, Efficient and Reliable System for Reduced Vehicle Fuel Consumption and CO<sub>2</sub> Emission
- Simplified Assembly, Optimized Layout, High Level of Integration, and Improved Thermal Performance

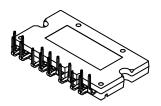


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APMCA-A16 16 LEAD CASE MODGF



APMCA-B16 16 LEAD CASE MODGJ

#### **MARKING DIAGRAM**

XXXXXXXXXX ZZZ ATYWW NNNNNNN

XXXX = Specific Device Code

ZZZ = Lot ID

AT = Assembly & Test Location

Y = Year W = Work Week NNN = Serial Number

#### ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 2 of this data sheet.

#### **ORDERING INFORMATION**

Part Number	Package	Lead Forming	Snubber Capacitor Inside	DBC Material	Pb-Free and RoHS Compliant	Operating Temperature (T <sub>A</sub> )	Packing Method
NXV65HR51DZ1	APM16-CAA	Y-Shape	No	Al <sub>2</sub> O <sub>3</sub>	Yes	−40°C ~ 125°C	Tube
NXV65HR51DZ2	APM16-CAB	L-Shape	No	Al <sub>2</sub> O <sub>3</sub>	Yes	−40°C ~ 125°C	Tube

#### **Pin Configuration and Description**

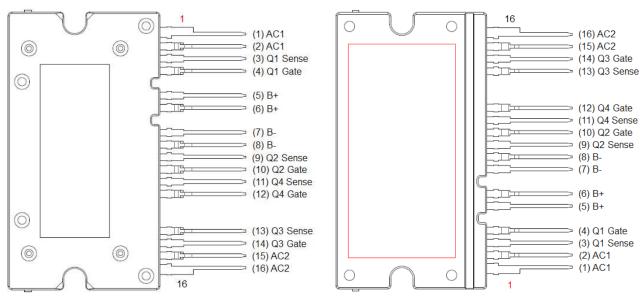


Figure 1. Pin Configuration

**Table 1. PIN DESCRIPTION** 

Pin Number	Pin Name	Pin Description	
1, 2	AC1	Phase 1 Leg of the H-Bridge	
3	Q1 Sense	Source Sense of Q1	
4	Q1 Gate	Gate Terminal of Q1	
5, 6	B+	Positive Battery Terminal	
7, 8	B-	Negative Battery Terminal	
9	Q2 Sense	Source Sense of Q2	
10	Q2 Gate	Gate Terminal of Q2	
11	Q4 Sense	Source Sense of Q4	
12	Q4 Gate	Gate Terminal of Q4	
13	Q3 Sense	Source Sense of Q3	
14	Q3 Gate	Gate Terminal of Q3	
15, 16	AC2	Phase 2 Leg of the H-Bridge	

#### **Internal Equivalent Circuit**

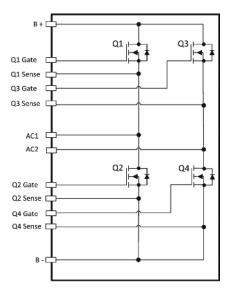


Figure 2. Internal Block Diagram

Table 2. ABSOLUTE MAXIMUM RATINGS (T<sub>J</sub> = 25°C, Unless Otherwise Specified)

Symbol	Parameter	Max	Unit
V <sub>DS</sub> (Q1~Q4)	Drain-to-Source Voltage	650	V
V <sub>GS</sub> (Q1~Q4)	Gate-to-Source Voltage	±20	V
I <sub>D</sub> (Q1~Q4)	Drain Current Continuous (T <sub>C</sub> = 25°C, V <sub>GS</sub> = 10 V) (Note 1)	33	Α
	Drain Current Continuous (T <sub>C</sub> = 100°C, V <sub>GS</sub> = 10 V) (Note 1)	21	Α
E <sub>AS</sub> (Q1~Q4)	Single Pulse Avalanche Energy (Note 2)	623	mJ
$P_{D}$	Power Dissipation (Note 1)	135	W
T <sub>J</sub>	Maximum Junction Temperature	-55 to +150	°C
T <sub>C</sub>	Maximum Case Temperature	-40 to +125	°C
T <sub>STG</sub>	Storage Temperature	-40 to +125	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

2. Starting  $T_J = 25^{\circ}C$ ,  $I_{AS} = 6.5$  A,  $R_G = 25 \Omega$ 

#### **DBC Substrate**

0.63 mm Al<sub>2</sub>O<sub>3</sub> alumina with 0.3 mm copper on both sides.

#### **Lead Frame**

OFC copper alloy, 0.50 mm thick. Plated with 8  $\mu m$  to 25.4  $\mu m$  thick Matte Tin

#### Flammability Information

All materials present in the power module meet UL flammability rating class 94V-0.

#### **Compliance to RoHS Directives**

The power module is 100% lead free and RoHS compliant 2000/53/C directive.

#### Solder

Solder used is a lead free SnAgCu alloy.

Solder presents high risk to melt at temperature beyond 210°C. Base of the leads, at the interface with the package body, should not be exposed to more than 200°C during mounting on the PCB or during welding to prevent the re-melting of the solder joints.

Maximum continuous current and power, without switching losses, to reach T<sub>J</sub> = 150°C respectively at T<sub>C</sub> = 25°C and T<sub>C</sub> = 100°C; defined by design based on MOSFET R<sub>DS(ON)</sub> and R<sub>θJC</sub> and not subject to production test

Table 3 FLECTRICAL SPECIFICATIONS (Tue 25°C, Unless Otherwise Specified)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
BV <sub>DSS</sub>	Drain-to-Source Breakdown Voltage	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0 V	650	-	-	V
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 3.3 \text{ mA}$	3.0	-	5.0	V
R <sub>DS(ON)</sub>	Q1 – Q4 MOSFET On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A	-	44	51	mΩ
R <sub>DS(ON)</sub>	Q1 – Q4 MOSFET On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A, T <sub>J</sub> = 125°C (Note 3)	-	79	-	mΩ
9FS	Forward Transconductance	$V_{DS} = 20 \text{ V}, I_D = 20 \text{ A (Note 3)}$	-	30	-	S
I <sub>GSS</sub>	Gate-to-Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	-100	-	+100	nA
I <sub>DSS</sub>	Drain-to-Source Leakage Current	V <sub>DS</sub> = 650 V, V <sub>GS</sub> = 0 V	-	-	10	μΑ
DYNAMIC CHARACTERISTICS (Note 3)						
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 400 V	-	4864	-	pF
C <sub>oss</sub>	Output Capacitance	V <sub>GS</sub> = 0 V f = 1 MHz	-	109	-	pF
_		1 - 1 1011 12				_

 $V_{DS} = 0 \text{ to } \overline{520 \text{ V}}$ 

 $V_{GS} = 0 V$ f = 1 MHz

 $V_{DS} = 380 \text{ V}$ 

 $I_D = 20 A$ 

V<sub>GS</sub> = 0 to 10 V

рF

рF

Ω

nC

nC

nC

16

652

2

123

37.5

49

#### $\mathsf{Q}_{\mathsf{gd}}$ **SWITCHING CHARACTERISTICS**

Gate Resistance

**Total Gate Charge** 

 $C_{rss}$ 

Coss(eff)

 $R_g$ 

Q<sub>g(tot)</sub>

 $Q_{gs}$ 

Reverse Transfer Capacitance

Effective Output Capacitance

Gate-to-Source Gate Charge

Gate-to-Drain "Miller" Charge

t <sub>on</sub>	Turn-on Time	V <sub>DS</sub> = 400 V	-	87	-	ns
t <sub>d(on)</sub>	Turn-on Delay Time	I <sub>D</sub> = 20 A V <sub>GS</sub> = 10 V	ı	47	_	ns
t <sub>r</sub>	Turn-on Rise Time	$R_G = 4.7 \Omega$	ı	43	_	ns
t <sub>off</sub>	Turn-off Time	(Note 3)	ı	148	_	ns
t <sub>d(off)</sub>	Turn-off Delay Time		_	118	-	ns
t <sub>f</sub>	Turn-off Fall Time		=	29	-	ns

#### **BODY DIODE CHARACTERISTICS**

V <sub>SD</sub>	Source-to-Drain Diode Voltage	$I_{SD} = 20 \text{ A}, V_{GS} = 0 \text{ V}$	-	0.95	-	V
T <sub>rr</sub>	Reverse Recovery Time	$V_{DS} = 520 \text{ V}, I_{D} = 20 \text{ A},$	-	133	-	ns
$Q_{rr}$	Reverse Recovery Charge	d <sub>I</sub> /d <sub>t</sub> = 100 A/μs (Note 3)	-	669	_	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### **Table 4. THERMAL RESISTANCE**

Parameters			Тур	Max	Unit
R <sub>θJC</sub> (per chip)	R <sub>0JC</sub> (per chip) Q1~Q4 Thermal Resistance Junction-to-Case (Note 4)		0.66	0.92	°C/W
R <sub>0JS</sub> (per chip)	Q1~Q4 Thermal Resistance Junction-to-Sink (Note 5)	_	1.2	_	°C/W

Test method compliant with MIL STD 883-1012.1, from case temperature under the chip to case temperature measured below the package at the chip center, Cosmetic oxidation and discoloration on the DBC surface allowed

Table 5. ISOLATION (Isolation resistance at tested voltage from the base plate to control pins or power terminals.)

Test	Test Conditions	Isolation Resistance	Unit
Leakage @ Isolation Voltage (Hi-Pot)	$V_{AC} = 5 \text{ kV}, 60 \text{ Hz}$	100M <	Ω

<sup>3.</sup> Defined by design, not subject to production test

<sup>5.</sup> Defined by thermal simulation assuming the module is mounted on a 5 mm Al-360 die casting material with 30 μm of 1.8 W/mK thermal interface material

## PARAMETER DEFINITIONS

Reference to Table 3: Parameter of Electrical Specifications

BV <sub>DSS</sub>	Q1 – Q4 MOSFET Drain-to-Source Breakdown Voltage The maximum drain-to-source voltage the MOSFET can endure without the avalanche breakdown of the body- drain P-N junction in off state. The measurement conditions are to be found in Table 3. The typ. Temperature behavior is described in Figure 13
V <sub>GS(th)</sub>	Q1 – Q4 MOSFET Gate to Source Threshold Voltage The gate–to–source voltage measurement is triggered by a threshold ID current given in conditions at Table 3. The typ. Temperature behavior can be found in Figure 12
R <sub>DS(ON)</sub>	Q1 – Q4 MOSFET On Resistance RDS(on) is the total resistance between the source and the drain during the on state. The measurement conditions are to be found in Table 3. The typ behavior can be found in Figure 10 and Figure 11 as well as Figure 17
9FS	Q1 $-$ Q4 MOSFET Forward Transconductance Transconductance is the gain in the MOSFET, expressed in the Equation below. It describes the change in drain current by the change in the gate–source bias voltage: $g_{fs} = [\Delta I_{DS} / \Delta V_{GS}]_{VDS}$
I <sub>GSS</sub>	Q1 – Q4 MOSFET Gate–to–Source Leakage Current The current flowing from Gate to Source at the maximum allowed VGS The measurement conditions are described in the Table 3.
I <sub>DSS</sub>	Q1 – Q4 MOSFET Drain–to–Source Leakage Current Drain – Source current is measured in off state while providing the maximum allowed drain–to-source voltage and the gate is shorted to the source. IDSS has a positive temperature coefficient.

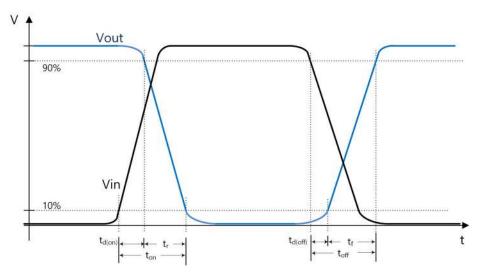


Figure 3. Timing Measurement Variable Definition

#### Table 6. PARAMETER OF SWITCHING CHARACTERISTICS

Turn-On Delay (t <sub>d(on)</sub> )	This is the time needed to charge the input capacitance, Ciss, before the load current ID starts flowing. The measurement conditions are described in the Table 3. For signal definition please check Figure 3 above.
Rise Time (t <sub>r</sub> )	The rise time is the time to discharge output capacitance, Coss. After that time the MOSFET conducts the given load current ID. The measurement conditions are described in the Table 3. For signal definition please check Figure 3 above.
Turn-On Time (t <sub>on</sub> )	Is the sum of turn-on-delay and rise time
Turn-Off Delay (t <sub>d(off)</sub> )	td(off) is the time to discharge Ciss after the MOSFET is turned off. During this time the load current ID is still flowing The measurement conditions are described in the Table 3. For signal definition please check Figure 3 above.
Fall Time (t <sub>f</sub> )	The fall time, tf, is the time to charge the output capacitance, Coss.  During this time the load current drops down and the voltage VDS rises accordingly.  The measurement conditions are described in the Table 3.  For signal definition please check Figure 3 above.
Turn-Off Time (t <sub>off</sub> )	Is the sum of turn-off-delay and fall time

#### **TYPICAL CHARACTERISTICS**

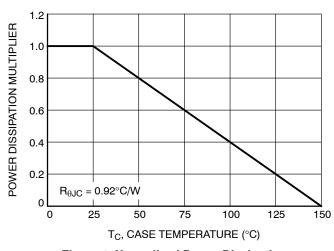


Figure 4. Normalized Power Dissipation vs. Case

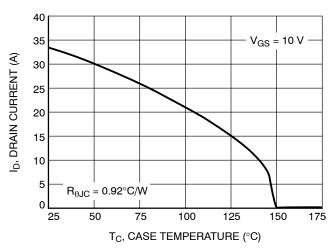


Figure 5. Maximum Continuous I<sub>D</sub> vs. Case Temperature

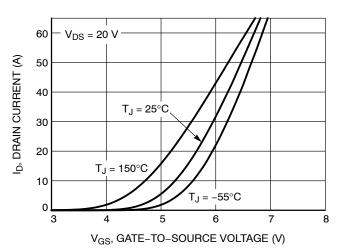


Figure 6. Transfer Characteristics

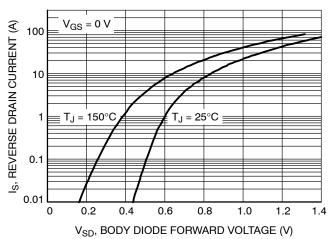


Figure 7. Forward Diode

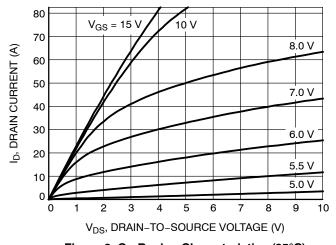


Figure 8. On Region Characteristics (25°C)

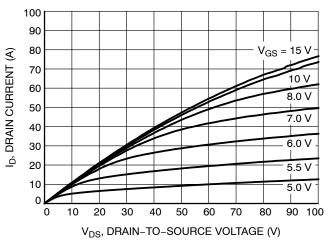
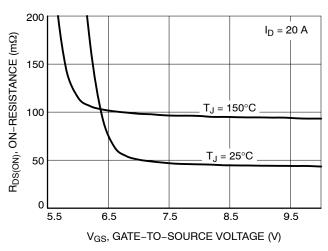


Figure 9. On Region Characteristics (150°C)

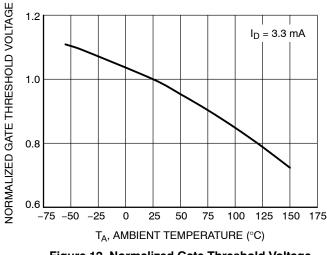
#### TYPICAL CHARACTERISTICS



 $I_D = 20 A$ R<sub>DS(ON)</sub>, NORMALIZED DRAIN-TO-SOURCE ON-RESISTANCE V<sub>GS</sub> = 10 V 2.0 1.5 1.0 0.5 -75 -50 -25 25 50 75 100 125 150 175 T<sub>J</sub>, JUNCTION TEMPERATURE (°C)

Figure 10. On-Resistance vs. Gate-to-Source Voltage

Figure 11. R<sub>DS(norm)</sub> vs. Junction Temperature



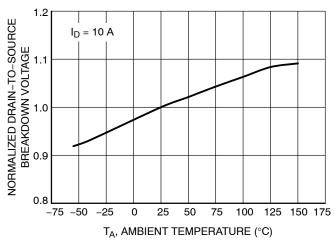
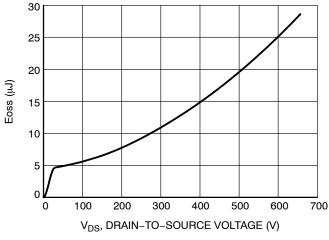


Figure 12. Normalized Gate Threshold Voltage vs. Temperature

Figure 13. Normalized Breakdown Voltage vs. Temperature



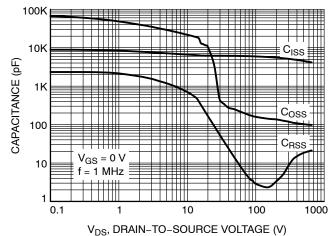


Figure 14. Eoss vs. Drain-to-Source Voltage

Figure 15. Capacitance Variation

#### **TYPICAL CHARACTERISTICS**

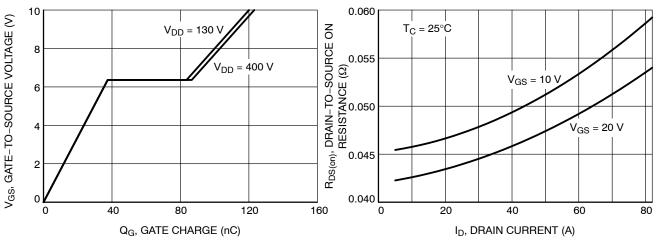


Figure 16. Gate Charge Characteristics

Figure 17. On Resistance Variation with Drain Current and Gate Voltage

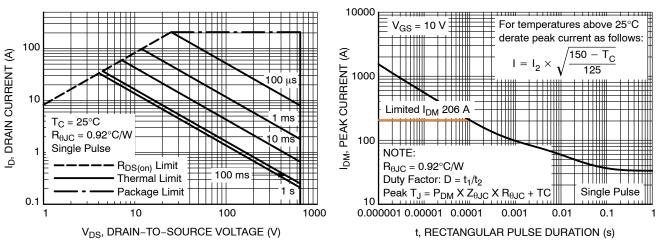


Figure 18. Safe Operating Area

Figure 19. Peak Current Capability

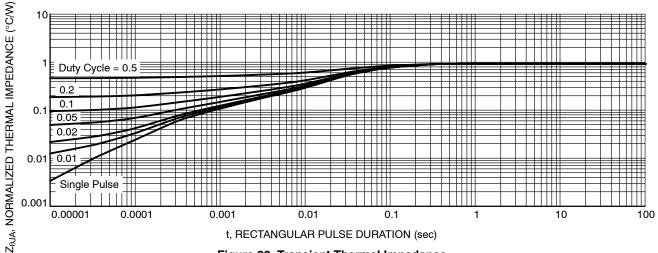
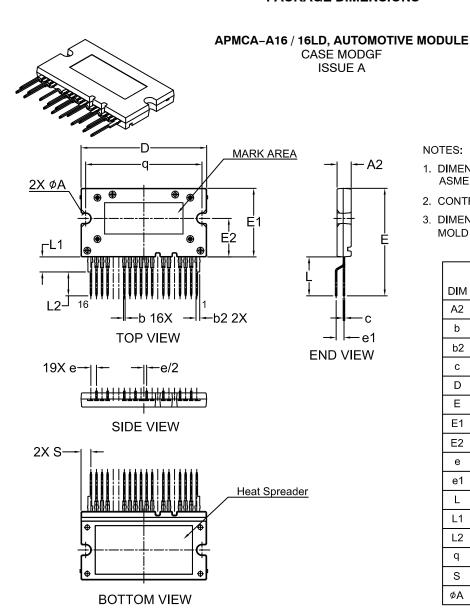


Figure 20. Transient Thermal Impedance

#### **PACKAGE DIMENSIONS**



#### NOTES:

1. DIMENSIONING AND TOLERANCING PER. ASME Y14.5M, 2009.

**DATE 02 MAY 2019** 

- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR EXTRUSIONS.

	MILLIMETERS			
DIM	MIN.	NOM.	MAX.	
A2	4.30	4.50	4.70	
b	0.45	0.50	0.60	
b2	1.15	1.20	1.30	
С	0.45	0.50	0.60	
D	39.90	40.10	40.30	
Е	33.80	34.30	34.80	
E1	21.70	21.90	22.10	
E2	12.10	12.30	12.50	
е	1.478	1.778	2.078	
e1	2.20	2.50	2.80	
L	12.10	12.40	12.70	
L1		4.80 REF		
L2	7.30	7.60	7.90	
q	36.85	37.10	37.35	
s	3.159 REF			
ØΑ	2.95	3.20	3.45	

#### PACKAGE DIMENSIONS

## APMCA-B16 / 16LD, AUTOMOTIVE MODULE **CASE MODGJ ISSUE A** MARK AREA - A2 2X ØA F2 TOP VIEW -b2 2X b 16X-**END VIEW** 19X e-SIDE VIEW 2X S-Heat Spreader

#### NOTES:

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**DATE 02 MAY 2019** 

- 2. CONTROLLING DIMENSION: MILLIMETERS
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	MILLIMETERS			
DIM	MIN.	NOM.	MAX.	
A2	4.30	4.50	4.70	
b	0.45	0.50	0.60	
b2	1.15	1.20	1.30	
С	0.45	0.50	0.60	
D	39.90	40.10	40.30	
Е	26.20	26.70	27.20	
E1	21.70	21.90	22.10	
E2	12.10	12.30	12.50	
е	1.478	1.778	2.078	
e1	2.20	2.50	2.80	
L	9.20	9.55	9.90	
L1	5.05 REF			
q	36.85	37.10	37.35	
S	3.159 REF			
ØΑ	2.95	3.20	3.45	

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